		Atty. Docket No. 1017D3	Serial No. 10/774,874
		LIST OF CITATIONS BY APPLICANT (Use several sheets if necessary)	
		Applicant Robert B. Hodek et al.	
		Filing Date February 9, 2004	Group

## U.S. PATENT DOCUMENTS

Exam. Init.		Document No.	Date	Name	Class	Subclass	Filing Date if appropriate
21	AA	1,836,354	12/31	Abrams	--	--	
	AB	1,877,336	9/32	Lovell et al.	--	--	
	AC	2,086,225	7/37	Hiering	113	116	
	AD	2,097,927	11/37	Klemp	113	116	
	AE	2,149,882	3/39	Clements	29	148	
	AF	2,173,664	9/39	Shutts	20	56.5	
	AG	2,219,595	10/40	Lang	29	148	
	AH	2,235,680	3/41	Haven et al.	20	56.5	
	AI	2,348,307	5/44	Richardson	20	56.5	
✓	AJ	2,587,063	2/52	Petsch	20	56.5	
21	AK	2,625,717	1/53	Wampler et al.	20	56.5	

## FOREIGN PATENT DOCUMENTS

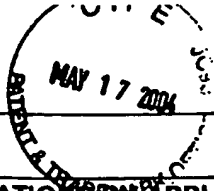
		Document No.	Date	Country	Class	Subclass	Translation	
							Yes	No
21	AL	639,955	7/50	Great Britain				
	AM	206 130	11/59	Germany				
21	AN	121019	3/60	New Zealand				
21	AO	898,981	6/62	Great Britain				
21	AP	1,918,528	11/70	Germany				
	AQ	481423	5/77	Australia				

## OTHER CITATIONS (Including Author, Title, Date, Pertinent Pages, Etc.)

21	AR	"IBM Technical Disclosure Bulletin" Vol. 11, No. 2, July 1968
21	AS	"Super Spacer™", Edgetech I.G. Ltd., May 1988
21	AT	Glover et al.; "Super Spacer™ Technical Report", Edgetech I.G. Ltd., May 1988

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21	AA	2,708,774	5/55	Seelen	20	56.5	
	AB	2,750,637	6/56	Browne	20	56.5	
	AC	2,768,475	10/56	Seelen et al.	49	81	
	AD	2,831,244	4/58	Adell	29	476	
	AE	2,885,746	5/59	Gura	20	56.5	
	AF	2,974,377	3/61	Kunkle	20	26.5	
	AG	2,977,722	4/61	Mazzoni	49	82	
	AH	3,021,243	2/62	Bethge	156	272	
	AI	3,026,582	3/62	Bayer	20	56.5	
21	AJ	3,030,673	4/62	London	20	56.5	
21	AK	3,045,297	7/62	Ljungdahl	20	56.5	

## FOREIGN PATENT DOCUMENTS

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							Yes	No
21	AL	2,619,718	11/77	Germany				
21	AM	1,509,178	4/78	Great Britain				
	AN	493482	5/78	Australia				
21	AO	30 40 407	10/79	Germany			X	
21	AP	2,923,769	1/80	Germany				
21	AQ	80 17 644	10/80	Germany			X	

## OTHER CITATIONS (Including Author, Title, Date, Pertinent Pages, Etc.)

21	AR	Wright et al., "Thermal Resistance Measurement of Glazing System Edge-Seals and Seal Materials Using a Guarded Heater Plate Apparatus", November 1989
21	AS	"Superglass™ System With Heat Mirror Film", January 1990
21	AT	"Introducing Super Spacer™ PIB", September 1, 1990

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21	AA	3,054,153	9/62	Partsch	20	56.5	
	AB	3,105,274	10/63	Armstrong	20	56.5	
	AC	3,212,179	10/65	Koblensky	29	451	
	AD	3,267,569	8/66	Eichhorn et al.	29	471.5	
	AE	3,280,523	10/66	Stroud et al.	52	172	
	AF	3,283,890	11/66	Morris et al.	206	59	
	AG	3,333,354	8/67	Kuliczowski et al.	29	604	
	AH	3,406,054	10/68	Chaffee	156	250	
	AI	3,427,366	2/69	Verdol et al.	260	859	
✓	AJ	3,445,436	5/69	Lake et al.	260	75	
21	AK	3,478,483	11/69	Baker	52	658	

## FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation	
							Yes	No
21	AL	1,585,544	3/81	Great Britain				
21	AM	57-14436	1/82	Japan (abstract)				
21	AN	3,044,179	6/82	Germany				
21	AO	3,302,659	8/84	Germany				
21	AP	8201396.9	10/84	Germany			X	
21	AQ	0 241 665	10/87	EP				

## OTHER CITATIONS (Including Author, Title, Date, Pertinent Pages, Etc.)

21	AR	"What Is Warm Edge Technology"; Glass Digest, pps. 74-76; March 1991
21	AS	Advertisement from Lockformer Company (no date)
	AT	

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21	AA	3,657,900	4/72	Bowser et al.	62	388	
	AB	3,674,743	7/72	Verdol et al.	260	73 L	
	AC	3,758,996	9/73	Bowser	52	172	
	AD	3,768,223	10/73	Kurz	52	658	
	AE	3,771,276	11/73	Stewart et al.	52	172	
	AF	3,775,914	12/73	Patril	52	172	
	AG	3,832,254	8/74	Bowser et al.	156	107	
	AH	3,867,107	2/75	Long et al.	29	190	
	AI	3,877,275	4/75	Attwood	72	177	
21	AJ	3,911,554	10/75	Ford	29	527.2	
21	AK	3,919,023	11/75	Bowser et al.	156	107	

## FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation	
							Yes	No
21	AL	0 261 923	3/88	EPO				
21	AM	206499	8/88	New Zealand				
21	AN	2,202,261	9/88	Great Britain				
21	AO	0 328 823	8/89	EP				
21	AP	223888	10/90	New Zealand				
21	AQ	0 430 889	11/90	EPO				

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2/	AA	3,923,748	12/75	Hutt et al.	260	77.5	
	AB	3,935,683	2/76	Demer et al.	52	172	
	AC	3,974,823	8/76	Patil	126	271	
	AD	4,015,394	4/77	Kessler	52	616	
	AE	4,057,945	11/77	Kessler	52	398	
	AF	4,063,002	12/77	Wilson, Jr.	428	411	
	AG	4,069,630	1/78	Chess et al.	52	171	
	AH	4,080,482	3/78	Iacombe	428	34	
	AI	4,109,431	8/78	Mazzoni et al.	52	172	
	AJ	4,132,539	1/79	Jeffries	65	40	
2/	AK	4,153,594	5/78	Wilson, Jr.	260	31.8	

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		Document No.	Date	Country	Class	Subclass	Translation	
							Yes	No
2/	AL	0 403 058	12/90	EPO				
2/	AM	WO91/00409	1/91	PCT WIPO				
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	AO							
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Exam. Init.		Document No.	Date	Name	Class	Subclass	Filing Date if appropriate
21	AA	4,222,213	9/80	Kessler	52	790	
	AB	4,269,255	5/81	Nailor et al.	160	381	
	AC	4,270,688	6/81	Janssens et al.	228	5.1	
	AD	4,318,959	3/82	Evans et al.	428	364	
	AE	4,350,515	9/82	Stewart	65	40	
	AF	4,431,691	2/84	Greenlee	428	34	
	AG	4,542,611	9/85	Day	52	172	
	AH	4,455,796	6/84	Schoofs	52	172	
	AI	4,464,874	8/84	Shea, Jr. et al.	52	398	
	AJ	4,520,611	6/85	Shingu et al.	52	789	
21	AK	4,546,723	10/85	Leopold et al.	118	669	

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21	AA	4,564,540	1/86	Davies et al.	428	34	
	AB	4,574,553	3/86	Lisec	52	658	
	AC	4,581,807	4/86	Adell	29	527.4	
	AD	4,583,257	8/89	Henery	427	166	
	AE	4,590,240	5/86	Streeter et al.	525	123	
	AF	4,597,232	7/86	Lingemann	52	304	
	AG	4,610,771	9/86	Gillery	204	192.1	
	AH	4,622,249	11/86	Bowser	428	34	
	AI	4,649,685	3/87	Wolf et al.	52	398	
✓	AJ	4,669,241	6/87	Kelly	52	400	
21	AK	4,710,411	12/87	Gerace et al.	428	34	

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							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							
	AQ							

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Exam. Init.		Document No.	Date	Name	Class	Subclass	Filing Date if appropriate
2/	AA	4,780,164	10/88	Rueckheim et al.	156	104	
	AB	4,780,521	10/88	Duck et al.	528	75	
	AC	4,806,220	2/89	Finley	204	192.27	
	AD	4,807,419	2/89	Hodek et al.	52	788	
	AE	4,807,439	2/89	Hain et al.	60	602	
	AF	4,808,452	2/89	McShane	428	34	
	AG	4,817,354	4/89	Bayer	52	302	
	AH	4,831,799	5/89	Glover et al.	52	172	
	AI	4,850,175	7/89	Berdan	52	790	
✓	AJ	4,853,256	8/89	Obringer et al.	427	152	
2/	AK	4,853,257	8/89	Henery	427	166	

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		Document No.	Date	Country	Class	Subclass	Translation	
							Yes	No
	AL							
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<u>2/</u>	AA	4,863,774	9/89	Tucker	428	77	
	AB	4,873,803	10/89	Rundo	52	202	
	AC	4,933,032	6/90	Kunert	52	108	
	AD	4,950,344	8/90	Glover et al.	156	109	
	AE	4,952,430	8/90	Bowser et al.	428	34	
	AF	4,969,250	11/90	Hickman et al.	29	521	
	AG	4,969,346	11/90	Bosl et al.	72	177	
	AG	4,994,309	2/91	Reichert et al.	428	34	
	AH	5,088,258	2/92	Schild et al.	52	398	
	AI	5,156,894	10/92	Hood et al.	428	34	
<u>✓</u>	AJ	5,177,916	1/93	Misera et al.	52	172	
<u>2/</u>	AK	5,246,331	9/93	Hallahan et al.	414	676	

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21	AA	5,255,481	10/93	Misera et al.	52	172	
	AB	5,290,611	3/94	Taylor	428	34	
	AC	5,302,425	4/94	Taylor	428	34	
	AD	5,377,473	1/95	Narayan et al.	52	790	
	AE	5,531,047	7/96	Leopold et al.	52	172	
	AF	5,546,708	8/96	Efstratis et al.	52	36.2	
	AG	5,632,122	5/97	Spinks	52	172	
	AH	5,655,282	8/97	Hodek et al.	29	469.5	
	AI	5,683,764	11/97	Alts	428	34	
21	AJ	5,813,191	9/98	Gallagher	52	786.13	
	AK	5,873,203	2/99	Thiel	52	172	

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21	AA	6,029,885	2/00	Mueller	229	125.19	
21	AB	6,223,414B1	5/01	Hodek et al.	29	527.1	
21	AC	6,266,940	7/01	Reichert	52	786.13	
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

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	AN							
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	AP							
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